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Appl. No. : 10/664,196
Applicant : Thomas BATZINGER, et al.
Filed : September 17, 2003
Title : SYSTEM AND METHOD FOR MONITORING
DEFECTS IN STRUCTURES
Art Unit : 2863
Examiner : Tung S. Lau
Confirmation No. : 3895

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

AMENDMENT

In response to the Office action of January 12, 2005, applicant respectfully requests the following amendments be entered into the above-identified application and reconsideration based upon the amendments and the following remarks.

A claims list begins on page 2 of this paper.

Remarks begin on page 6 of this paper.